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**3619****U.S. PATENT DOCUMENTS**

Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date (if appropriate)
<i>JR</i>	6,185,485	02/2001	Ashrafi et al.	701	1	
<i>JR</i>	6,130,608	10/2000	McKeown et al.	340	438	
<i>JR</i>	6,092,617	07/2000	White, III et al.	180	338	
<i>JR</i>	6,009,368	12/1999	Labuhn et al.	701	96	
<i>JR</i>	6,002,975	12/1999	Schiffmann et al.	701	36	
<i>JR</i>	5,931,546	08/1999	Nakashima et al.	303	146	
<i>JR</i>	5,900,819	05/1999	Kyrtos	340	576	
<i>JR</i>	5,878,357	03/1999	Sivashankar et al.	701	1	
<i>JR</i>	5,742,918	04/1998	Ashrafi et al.	701	70	
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<i>JR</i>	5,732,377	03/1998	Eckert	701	426	
<i>JR</i>	5,627,756	05/1997	Fukada et al.	364	426.01	
<i>JR</i>	5,548,273	08/1996	Nicol et al.	340	439	

**FOREIGN PATENT DOCUMENTS**

Examiner Initial	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No

**RECEIVED****MAY 04 2001****TO 3600 MAIL ROOM****OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)**

	Texas Instruments, "3-V Accelerometer Featuring TLV2772 Application Report," 1998

EXAMINER

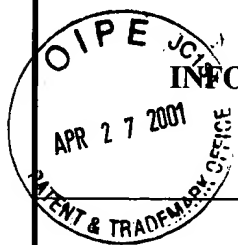
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## INFORMATION DISCLOSURE CITATION

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<i>R</i>	5,473,930	12/1995	Gademann et al.	73	1 D	
<i>R</i>	5,369,580	11/1994	Monji et al.	364	424.01	
<i>R</i>	5,276,624	01/1994	Ito et al.	364	424.05	
<i>R</i>	5,269,187	12/1993	Hanson	73	495	
<i>R</i>	5,247,466	09/1993	Shimada et al.	364	566	
<i>R</i>	5,212,640	05/1993	Matsuda	364	424.03	
<i>R</i>	5,123,497	06/1992	Yopp et al.	180	142	
<i>R</i>	5,087,068	02/1992	Fukanaga et al.	280	707	
<i>R</i>	5,063,782	11/1991	Kellett	73	654	
<i>R</i>	4,908,767	03/1990	Scholl et al.	364	453	
<i>R</i>	4,890,231	12/1989	Frantz	364	426.04	
<i>R</i>	4,803,627	02/1989	Yasuike et al.	364	424.05	
<i>R</i>	4,522,280	06/1985	Blaney	180	175	

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						<i>Yes</i>	<i>No</i>

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)


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